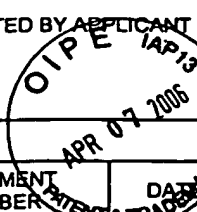

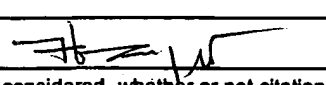
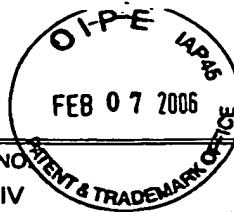


Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 251961US-3 DIV		SERIAL NO. 40/830,101 10/830,223	
LIST OF REFERENCES CITED BY APPLICANT 				APPLICANT Takaaki YANAGISAWA, et al.			
				FILING DATE RCE Filed July 11, 2005		GROUP 2852	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA						
	AB						
	AC						
	AD						
	AE						
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO		
	AF	2004-046268	2/2004	JAPAN (w/abstract)			
	AG	09-166912	6/1997	JAPAN (w/abstract)			
	AH	64-17550	1/1989	JAPAN	X		
	AI	2001-175083	6/2001	JAPAN (w/abstract)			
	AJ	1-24739	1/1986	JAPAN	X		
	AK	11-272075	10/1999	JAPAN (w/abstract)			
	AL	10-063087	3/1998	JAPAN (w/abstract)			
	AM	04-143781	5/1992	JAPAN (w/abstract)			
	AN	58-123444	8/1983	JAPAN	X		
	AO	10-293452	11/1998	JAPAN (w/abstract)			
	AP	04-134471	5/1992	JAPAN (w/abstract)			
	AQ	09-022175	1/1997	JAPAN (w/abstract)			
	AR	10-097130	4/1998	JAPAN (w/abstract)			
	AS	09-292773	11/1997	JAPAN (w/abstract)			
	AT						
	AU						
	AV						
OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, etc.)							
	AW						
	AX						
	AY						
	AZ						
Examiner 					<input type="checkbox"/> Additional References sheet(s) attached Date Considered 4/14/06		
*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							

Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 251961US3DIV		SERIAL NO. 10/830,223	
LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Takaaki YANAGISAWA, et al.			
				FILING DATE RCE Filed January 11, 2006		GROUP 2852	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE	
	AA						
	AB						
	AC						
	AD						
	AE						
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	AG						
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	AI						
	AJ						
	AK						
	AL						
	AM						
	AN						
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO		
# _n	AO	2000-227706	8/15/2000	Japan (with Abstract)		X	
# _n	AP	60-3856	1/12/1985	Japan	X		
	AQ						
	AR						
	AS						
	AT						
	AU						
	AV						
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
	AW						
	AX						
	AY						
	AZ						
					<input type="checkbox"/> Additional References sheet(s) attached		
Examiner <i>76-215</i>					Date Considered <i>4/14/06</i>		
<small>*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.</small>							



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LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Takaaki YANAGISAWA, et al.			
				RCE FILED January 11, 2006		GROUP 2852	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
Hu	AA	4,984,023	January-91	Yoshida			
Hu	AB	5,412,364	January-97	Iguchi et al.			
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO		
Hu	AJ	JP 60-232578	November-85	JAPAN (w/abstract)			X
Hu	AK	JP 08-171331	July-96	JAPAN (w/abstract)			X
	AL						
	AM						
	AN						
	AO						
	AP						
	AQ						
	AR						
	AS						
	AT						
	AU						
	AV						
	AW						
	AX						
	AY						
	AZ						
	AAA						
	AAB						
	AAC						
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
					<input type="checkbox"/> Additional References sheet(s) attached		
Examiner <i>Hu</i>					Date Considered <i>4/14/06</i>		
*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							

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<div style="border: 1px solid black; border-radius: 50%; padding: 10px; display: inline-block;"> PIPE JAN 11 2006 PATENT & TRADEMARK OFFICE </div>				APPLICANT Takaaki YANAGISAWA, et al.				
LIST OF REFERENCES CITED BY APPLICANT				RCE FILED Herewith		GROUP 2852		
U.S. PATENT DOCUMENTS								
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE	
H _n	AA	5,740,507	4/14/98	Ichikawa et al.				
H _n	AB	5,655,195	8/5/97	Ichikawa et al.				
H _n	AC	5,950,055	9/7/99	Yahata et al.				
H _n	AD	5,915,154	6/22/99	Schoch et al.				
H _n	AE	5,570,170	10/29/96	Muranyi et al.				
H _n	AF	4,274,455	6/23/81	Simons				
H _n	AG	4,945,956	8/7/90	Bueyuekgueclue et al.				
H _n	AH	4,503,625	3/12/85	Manzer				
H _n	AI	5,848,326	12/8/98	Komuro et al.				
FOREIGN PATENT DOCUMENTS								
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO			
H _n	AJ	JP 2000-128192	May-2000	JAPAN (w/abstract)			X	
H _n	AK	EP 1,014,214	Jun-2005	EUROPEAN				
H _n	AL	EP 1,193,570	Nov-2004	EUROPEAN				
H _n	AM	JP 08-211723	Aug-1996	JAPAN (w/abstract)			X	
H _n	AN	JP 03-241372	Oct-1991	JAPAN (w/abstract)			X	
H _n	AO	JP 08-292636	Nov-1996	JAPAN (w/abstract)			X	
H _n	AP	JP 02-053055	Feb-1990	JAPAN (w/abstract)			X	
H _n	AQ	JP 08-314272	Nov-1996	JAPAN (w/abstract)			X	
H _n	AR	JP 04-087901	Mar-1992	JAPAN (w/abstract)			X	
H _n	AS	JP 09-106156	Apr-1997	JAPAN (w/abstract)			X	
H _n	AT	JP 61-059464	Mar-1986	JAPAN (w/abstract)			X	
H _n	AU	JP 64-052181	Feb-1989	JAPAN (w/abstract)			X	
H _n	AV	JP 08-171281	Jul-1996	JAPAN (w/abstract)			X	
H _n	AW	JP 05-232810	Sep-1993	JAPAN (w/abstract)			X	
H _n	AX	JP 57-057451	Apr-1982	JAPAN (w/abstract)			X	
H _n	AY	JP 06-208301	Jul-1994	JAPAN (w/abstract)			X	
H _n	AZ	JP 07-261529	Oct-1995	JAPAN (w/abstract)			X	
H _n	AAA	JP 06-191049	Jul-1994	JAPAN (w/abstract)			X	
H _n	AAB	JP 09-305080	Nov-1997	JAPAN (w/abstract)			X	
H _n	AAC	JP 06-059572	Mar-1994	JAPAN (w/abstract)			X	
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)								
					<input type="checkbox"/> Additional References sheet(s) attached			
Examiner					Date Considered 4/14/06			
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